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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "Embedded - Microcontrollers"

Details	
Product Status	Active
Core Processor	e200z4d
Core Size	32-Bit Dual-Core
Speed	120MHz
Connectivity	CANbus, LINbus, SCI, SPI, UART/USART
Peripherals	DMA, LVD, POR, PWM, WDT
Number of I/O	57
Program Memory Size	1MB (1M x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	128K x 8
Voltage - Supply (Vcc/Vdd)	3V ~ 3.63V
Data Converters	A/D 32x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 125°C (TA)
Mounting Type	Surface Mount
Package / Case	100-LQFP
Supplier Device Package	100-LQFP (14x14)
Purchase URL	https://www.e-xfl.com/product-detail/stmicroelectronics/spc56el60l3ccfqr

The RC oscillator provides these features:

- Nominal frequency 16 MHz
- ±5% variation over voltage and temperature after process trim
- Clock output of the RC oscillator serves as system clock source in case loss of lock or loss of clock is detected by the FMPLL
- RC oscillator is used as the default system clock during startup and can be used as back-up input source of FMPLL(s) in case XOSC fails

1.5.17 Clock, reset, power, mode and test control modules (MC_CGM, MC_RGM, MC_PCU, and MC_ME)

These modules provide the following:

- Clock gating and clock distribution control
- Halt, stop mode control
- Flexible configurable system and auxiliary clock dividers
- Various execution modes
  - HALT and STOP mode as reduced activity low power mode
  - Reset, Idle, Test, Safe
  - Various RUN modes with software selectable powered modules
  - No stand-by mode implemented (no internal switchable power domains)

1.5.18 Periodic Interrupt Timer Module (PIT)

The PIT module implements the following features:

- 4 general purpose interrupt timers
- 32-bit counter resolution
- Can be used for software tick or DMA trigger operation

1.5.19 System Timer Module (STM)

The STM implements the following features:

- Up-counter with 4 output compare registers
- OS task protection and hardware tick implementation per AUTOSAR[(a)] requirement

The STM is replicated for each processor.

1.5.20 Software Watchdog Timer (SWT)

This module implements the following features:

- Fault tolerant output
- Safe internal RC oscillator as reference clock
- Windowed watchdog
- Program flow control monitor with 16-bit pseudorandom key generation
- Allows a high level of safety (SIL3 monitor)

a. Automotive Open System Architecture.

1.5.25 System Status and Configuration Module (SSCM)

The SSCM on this device features the following:

- System configuration and status
- Debug port status and debug port enable
- Multiple boot code starting locations out of reset through implementation of search for valid Reset Configuration Half Word
- Sets up the MMU to allow user boot code to execute as either Power Architecture code (default) or as VLE code out of flash memory
- Triggering of device self-tests during reset phase of device boot

1.5.26 FlexCAN

The FlexCAN module is a communication controller implementing the CAN protocol according to Bosch Specification version 2.0B. The CAN protocol was designed to be used primarily as a vehicle serial data bus, meeting the specific requirements of this field: real-time processing, reliable operation in the EMI environment of a vehicle, cost-effectiveness and required bandwidth.

The FlexCAN module provides the following features:

- Full implementation of the CAN protocol specification, version 2.0B
  - Standard data and remote frames
  - Extended data and remote frames
  - 0 to 8 bytes data length
  - Programmable bit rate as fast as 1Mbit/s
- 32 message buffers of 0 to 8 bytes data length
- Each message buffer configurable as receive or transmit buffer, all supporting standard and extended messages
- Programmable loop-back mode supporting self-test operation
- 3 programmable mask registers
- Programmable transmit-first scheme: lowest ID or lowest buffer number
- Time stamp based on 16-bit free-running timer
- Global network time, synchronized by a specific message
- Maskable interrupts
- Independent of the transmission medium (an external transceiver is assumed)
- High immunity to EMI
- Short latency time due to an arbitration scheme for high-priority messages
- Transmit features
  - Supports configuration of multiple mailboxes to form message queues of scalable depth
  - Arbitration scheme according to message ID or message buffer number
  - Internal arbitration to guarantee no inner or outer priority inversion
  - Transmit abort procedure and notification

1.5.28 Serial communication interface module (LINFlexD)

The LINFlexD module (LINFlex with DMA support) on this device features the following:

- Supports LIN Master mode, LIN Slave mode and UART mode
- LIN state machine compliant to LIN1.3, 2.0, and 2.1 specifications
- Manages LIN frame transmission and reception without CPU intervention
- LIN features
  - Autonomous LIN frame handling
  - Message buffer to store as many as 8 data bytes
  - Supports messages as long as 64 bytes
  - Detection and flagging of LIN errors (Sync field, delimiter, ID parity, bit framing, checksum and Time-out errors)
  - Classic or extended checksum calculation
  - Configurable break duration of up to 50-bit times
  - Programmable baud rate prescalers (13-bit mantissa, 4-bit fractional)
  - Diagnostic features (Loop back, LIN bus stuck dominant detection)
  - Interrupt driven operation with 16 interrupt sources
- LIN slave mode features
  - Autonomous LIN header handling
  - Autonomous LIN response handling
- UART mode
  - Full-duplex operation
  - Standard non return-to-zero (NRZ) mark/space format
  - Data buffers with 4-byte receive, 4-byte transmit
  - Configurable word length (8-bit, 9-bit, 16-bit, or 17-bit words)
  - Configurable parity scheme: none, odd, even, always 0
  - Speed as fast as 2 Mbit/s
  - Error detection and flagging (Parity, Noise and Framing errors)
  - Interrupt driven operation with four interrupt sources
  - Separate transmitter and receiver CPU interrupt sources
  - 16-bit programmable baud-rate modulus counter and 16-bit fractional
  - Two receiver wake-up methods
- Support for DMA enabled transfers

1.5.29 Deserial Serial Peripheral Interface (DSPI)

The DSPI modules provide a synchronous serial interface for communication between the SPC56ELx/SPC564Lx and external devices.

A DSPI module provides these features:

- Full duplex, synchronous transfers
- Master or slave operation
- Programmable master bit rates
- Programmable clock polarity and phase

1.5.33 Analog-to-Digital Converter module (ADC)

The ADC module features include:

Analog part:

- 2 on-chip ADCs
  - 12-bit resolution SAR architecture
  - Same digital interface as in the SPC560P family
  - A/D Channels: 9 external, 3 internal and 4 shared with other A/D (total 16 channels)
  - One channel dedicated to each T-sensor to enable temperature reading during application
  - Separated reference for each ADC
  - Shared analog supply voltage for both ADCs
  - One sample and hold unit per ADC
  - Adjustable sampling and conversion time

Digital part:

- 4 analog watchdogs comparing ADC results against predefined levels (low, high, range) before results are stored in the appropriate ADC result location
- 2 modes of operation: CPU Mode or CTU Mode
- CPU mode features
  - Register based interface with the CPU: one result register per channel
  - ADC state machine managing three request flows: regular command, hardware injected command, software injected command
  - Selectable priority between software and hardware injected commands
  - 4 analog watchdogs comparing ADC results against predefined levels (low, high, range)
  - DMA compatible interface
- CTU mode features
  - Triggered mode only
  - 4 independent result queues (1×16 entries, 2×8 entries, 1×4 entries)
  - Result alignment circuitry (left justified; right justified)
  - 32-bit read mode allows to have channel ID on one of the 16-bit parts
  - DMA compatible interfaces
- Built-in self-test features triggered by software

1.5.34 Cross Triggering Unit (CTU)

The ADC cross triggering unit allows automatic generation of ADC conversion requests on user selected conditions without CPU load during the PWM period and with minimized CPU load for dynamic configuration.

Table 4. LQFP144 pin function summary (continued)

Pin #	Port/function	Peripheral	Output function	Input function
117	E[13]	SIUL	GPIO[77]	GPIO[77]
		eTimer_0	ETC[5]	ETC[5]
		DSPI_2	CS3	—
		SIUL	—	EIRQ[25]
118	A[10]	SIUL	GPIO[10]	GPIO[10]
		DSPI_2	CS0	CS0
		FlexPWM_0	B[0]	B[0]
		FlexPWM_0	X[2]	X[2]
		SIUL	—	EIRQ[9]
119	E[14]	SIUL	GPIO[78]	GPIO[78]
		eTimer_1	ETC[5]	ETC[5]
		SIUL	—	EIRQ[26]
120	A[11]	SIUL	GPIO[11]	GPIO[11]
		DSPI_2	SCK	SCK
		FlexPWM_0	A[0]	A[0]
		FlexPWM_0	A[2]	A[2]
		SIUL	—	EIRQ[10]
121	E[15]	SIUL	GPIO[79]	GPIO[79]
		DSPI_0	CS1	—
		SIUL	—	EIRQ[27]
122	A[12]	SIUL	GPIO[12]	GPIO[12]
		DSPI_2	SOUT	—
		FlexPWM_0	A[2]	A[2]
		FlexPWM_0	B[2]	B[2]
		SIUL	—	EIRQ[11]
123	JCOMP	—	—	JCOMP
124	C[15]	SIUL	GPIO[47]	GPIO[47]
		FlexRay	CA_TR_EN	—
		eTimer_1	ETC[0]	ETC[0]
		FlexPWM_0	A[1]	A[1]
		CTU_0	—	EXT_IN
		FlexPWM_0	—	EXT_SYNC

Table 4. LQFP144 pin function summary (continued)

Pin #	Port/function	Peripheral	Output function	Input function
125	D[0]	SIUL	GPIO[48]	GPIO[48]
		FlexRay	CA_TX	—
		eTimer_1	ETC[1]	ETC[1]
		FlexPWM_0	B[1]	B[1]
126	$V_{DD\_HV\_IO}$	—		
127	$V_{SS\_HV\_IO}$	—		
128	D[3]	SIUL	GPIO[51]	GPIO[51]
		FlexRay	CB_TX	—
		eTimer_1	ETC[4]	ETC[4]
		FlexPWM_0	A[3]	A[3]
129	D[4]	SIUL	GPIO[52]	GPIO[52]
		FlexRay	CB_TR_EN	—
		eTimer_1	ETC[5]	ETC[5]
		FlexPWM_0	B[3]	B[3]
130	$V_{DD\_HV\_REG\_2}$	—		
131	$V_{DD\_LV\_COR}$	—		
132	$V_{SS\_LV\_COR}$	—		
133	F[0]	SIUL	GPIO[80]	GPIO[80]
		FlexPWM_0	A[1]	A[1]
		eTimer_0	—	ETC[2]
		SIUL	—	EIRQ[28]
134	A[9]	SIUL	GPIO[9]	GPIO[9]
		DSPI_2	CS1	—
		FlexPWM_0	B[3]	B[3]
		FlexPWM_0	—	FAULT[0]
135	$V_{DD\_LV\_COR}$	—		
136	A[13]	SIUL	GPIO[13]	GPIO[13]
		FlexPWM_0	B[2]	B[2]
		DSPI_2	—	SIN
		FlexPWM_0	—	FAULT[0]
		SIUL	—	EIRQ[12]
137	$V_{SS\_LV\_COR}$	—		

Table 5. LFBGA257 pin function summary (continued)

Pin #	Port/function	Peripheral	Output function	Input function
N14	Not connected	—		
N15	C[12]	SIUL	GPIO[44]	GPIO[44]
		eTimer_0	ETC[5]	ETC[5]
		DSPI_2	CS3	—
N16	A[2]	SIUL	GPIO[2]	GPIO[2]
		eTimer_0	ETC[2]	ETC[2]
		FlexPWM_0	A[3]	A[3]
		DSPI_2	—	SIN
		MC_RGM	—	ABS[0]
		SIUL	—	EIRQ[2]
N17	G[5]	SIUL	GPIO[101]	GPIO[101]
		FlexPWM_0	X[3]	X[3]
		DSPI_2	CS3	—
P1	$V_{SS\_HV\_OSC}$	—		
P2	RESET	—		
P3	D[6]	SIUL	GPIO[54]	GPIO[54]
		DSPI_0	CS2	—
		FlexPWM_0	X[3]	X[3]
		FlexPWM_0	—	FAULT[1]
P4	$V_{DD\_LV\_PLL0\_PLL1}$	—		
P5	$V_{DD\_LV\_CORE\_RING}$	—		
P6	$V_{SS\_LV\_CORE\_RING}$	—		
P7	B[8]	SIUL	—	GPIO[24]
		eTimer_0	—	ETC[5]
		ADC_0	—	AN[1]
P8	Not connected	—		
P9	$V_{SS\_HV\_IO\_RING}$	—		
P10	$V_{DD\_HV\_IO\_RING}$	—		
P11	B[14]	SIUL	—	GPIO[30]
		eTimer_0	—	ETC[4]
		SIUL	—	EIRQ[19]
		ADC_1	—	AN[1]
P12	$V_{DD\_LV\_CORE\_RING}$	—		
P13	$V_{SS\_LV\_CORE\_RING}$	—		
P14	$V_{DD\_HV\_IO\_RING}$	—		

Table 8. Pin muxing (continued)

Port name	PCR	Peripheral	Alternate output function	Output mux sel	Input functions	Input mux select	Weak pull config during reset	Pad speed(1)		Pin #		
								SRC = 1	SRC = 0	100 pkg	144 pkg	257 pkg
F[7]	PCR[87]	SIUL	GPIO[87]	ALT0	GPIO[87]	—	—	F	S	—	19	J1
		NPC	MCKO	ALT2	—	—						
F[8]	PCR[88]	SIUL	GPIO[88]	ALT0	GPIO[88]	—	—	F	S	—	20	K2
		NPC	MSEO[1]	ALT2	—	—						
F[9]	PCR[89]	SIUL	GPIO[89]	ALT0	GPIO[89]	—	—	F	S	—	23	K1
		NPC	MSEO[0]	ALT2	—	—						
F[10]	PCR[90]	SIUL	GPIO[90]	ALT0	GPIO[90]	—	—	F	S	—	24	L1
		NPC	EVTO	ALT2	—	—						
F[11]	PCR[91]	SIUL	GPIO[91]	ALT0	GPIO[91]	—	—	M	S	—	25	L2
		NPC	—	ALT2	EVTI	—						
F[12]	PCR[92]	SIUL	GPIO[92]	ALT0	GPIO[92]	—	—	M	S	—	106	C17
		eTimer_1	ETC[3]	ALT1	ETC[3]	PSMI[12]; PADSEL=2						
		SIUL	—	—	EIRQ[30]	—						
F[13]	PCR[93]	SIUL	GPIO[93]	ALT0	GPIO[93]	—	—	M	S	—	112	B14
		eTimer_1	ETC[4]	ALT1	ETC[4]	PSMI[13]; PADSEL=3						
		SIUL	—	—	EIRQ[31]	—						
F[14]	PCR[94]	SIUL	GPIO[94]	ALT0	GPIO[94]	—	—	M	S	—	115	C13
		LINFlexD_1	TXD	ALT1	—	—						
F[15]	PCR[95]	SIUL	GPIO[95]	ALT0	GPIO[95]	—	—	M	S	—	113	D13
		LINFlexD_1	—	—	RXD	PSMI[32]; PADSEL=2						

Table 8. Pin muxing (continued)

Port name	PCR	Peripheral	Alternate output function	Output mux sel	Input functions	Input mux select	Weak pull config during reset	Pad speed(1)		Pin #		
								SRC = 1	SRC = 0	100 pkg	144 pkg	257 pkg
G[11]	PCR[107]	SIUL	GPIO[107]	ALT0	GPIO[107]	—	—	M	S	—	75	U15
		FlexRay	DBG3	ALT1	—	—						
		FlexPWM_0	—	—	FAULT[3]	PSMI[19]; PADSEL=2						
G[12]	PCR[108]	SIUL	GPIO[108]	ALT0	GPIO[108]	—	—	F	S	—	—	F2
		NPC	MDO[11]	ALT2	—	—						
G[13]	PCR[109]	SIUL	GPIO[109]	ALT0	GPIO[109]	—	—	F	S	—	—	H1
		NPC	MDO[10]	ALT2	—	—						
G[14]	PCR[110]	SIUL	GPIO[110]	ALT0	GPIO[110]	—	—	F	S	—	—	A6
		NPC	MDO[9]	ALT2	—	—						
G[15]	PCR[111]	SIUL	GPIO[111]	ALT0	GPIO[111]	—	—	F	S	—	—	J2
		NPC	MDO[8]	ALT2	—	—						
Port H												
H[0]	PCR[112]	SIUL	GPIO[112]	ALT0	GPIO[112]	—	—	F	S	—	—	A5
		NPC	MDO[7]	ALT2	—	—						
H[1]	PCR[113]	SIUL	GPIO[113]	ALT0	GPIO[113]	—	—	F	S	—	—	F1
		NPC	MDO[6]	ALT2	—	—						
H[2]	PCR[114]	SIUL	GPIO[114]	ALT0	GPIO[114]	—	—	F	S	—	—	A4
		NPC	MDO[5]	ALT2	—	—						
H[3]	PCR[115]	SIUL	GPIO[115]	ALT0	GPIO[115]	—	—	F	S	—	—	G1
		NPC	MDO[4]	ALT2	—	—						

Equation 2: $R_{\theta JA} = R_{\theta JC} + R_{\theta CA}$

where:

$R_{\theta JA}$ = junction to ambient thermal resistance (°C/W)

$R_{\theta JC}$= junction to case thermal resistance (°C/W)

$R_{\theta CA}$= case to ambient thermal resistance (°C/W)

$R_{\theta JC}$ is device related and cannot be influenced by the user. The user controls the thermal environment to change the case to ambient thermal resistance, $R_{\theta CA}$. For instance, the user can change the size of the heat sink, the air flow around the device, the interface material, the mounting arrangement on printed circuit board, or change the thermal dissipation on the printed circuit board surrounding the device.

To determine the junction temperature of the device in the application when heat sinks are not used, the Thermal Characterization Parameter (Ψ_{JT}) can be used to determine the junction temperature with a measurement of the temperature at the top center of the package case using *Equation 3*:

Equation 3 $T_J = T_T + (\Psi_{JT} \times P_D)$

where:

T_T= thermocouple temperature on top of the package (°C)

Ψ_{JT}= thermal characterization parameter (°C/W)

P_D= power dissipation in the package (W)

The thermal characterization parameter is measured per JESD51-2 specification using a 40 gauge type T thermocouple epoxied to the top center of the package case. The thermocouple should be positioned so that the thermocouple junction rests on the package. A small amount of epoxy is placed over the thermocouple junction and over about 1 mm of wire extending from the junction. The thermocouple wire is placed flat against the package case to avoid measurement errors caused by cooling effects of the thermocouple wire.

3.5.1.1 References

Semiconductor Equipment and Materials International
3081 Zanker Road
San Jose, CA 95134 USA
(408) 943-6900

MIL-SPEC and EIA/JESD (JEDEC) specifications are available from Global Engineering Documents at 800-854-7179 or 303-397-7956.

JEDEC specifications are available on the WEB on JEDEC site.

1. C.E. Triplett and B. Joiner, “An Experimental Characterization of a 272 PBGA Within an Automotive Engine Controller Module,” Proceedings of SemiTherm, San Diego, 1998, pp. 47–54.
2. G. Kromann, S. Shidore, and S. Addison, “Thermal Modeling of a PBGA for Air-Cooled Applications,” Electronic Packaging and Production, pp. 53–58, March 1998.
3. B. Joiner and V. Adams, “Measurement and Simulation of Junction to Board Thermal Resistance and Its Application in Thermal Modeling,” Proceedings of SemiTherm, San Diego, 1999, pp. 212–220.

Figure 15. Destructive Reset Sequence, BIST disabled

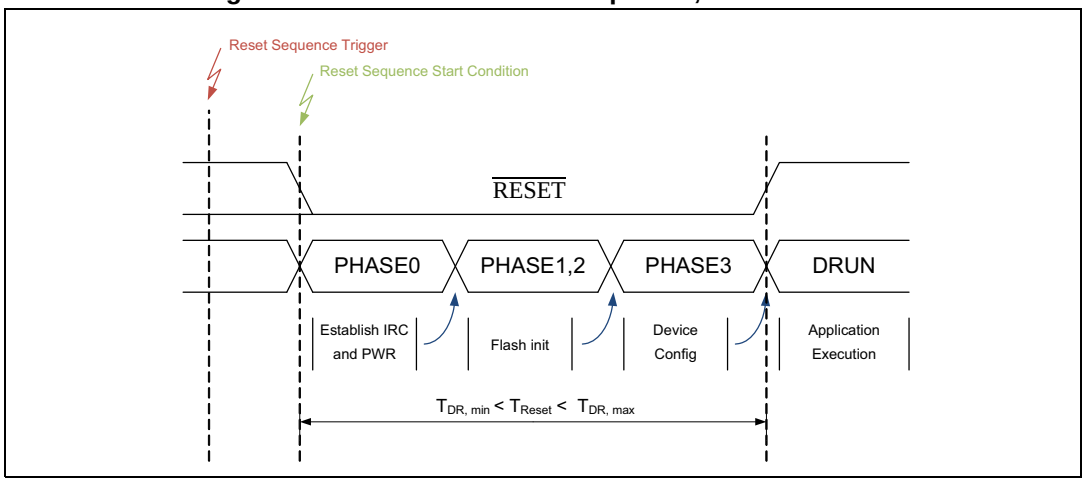


Figure 16. External Reset Sequence Long, BIST enabled

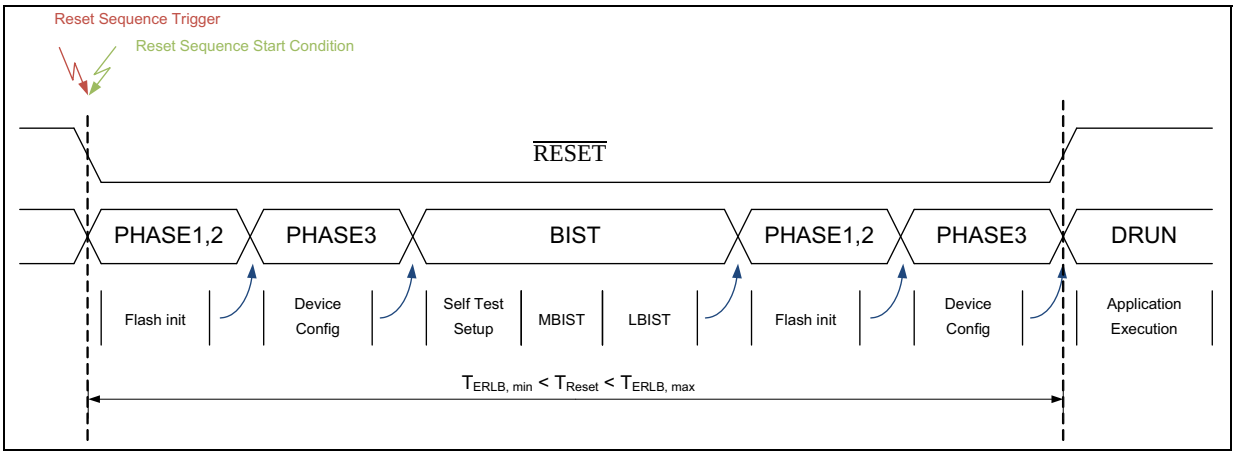


Figure 17. Functional Reset Sequence Long

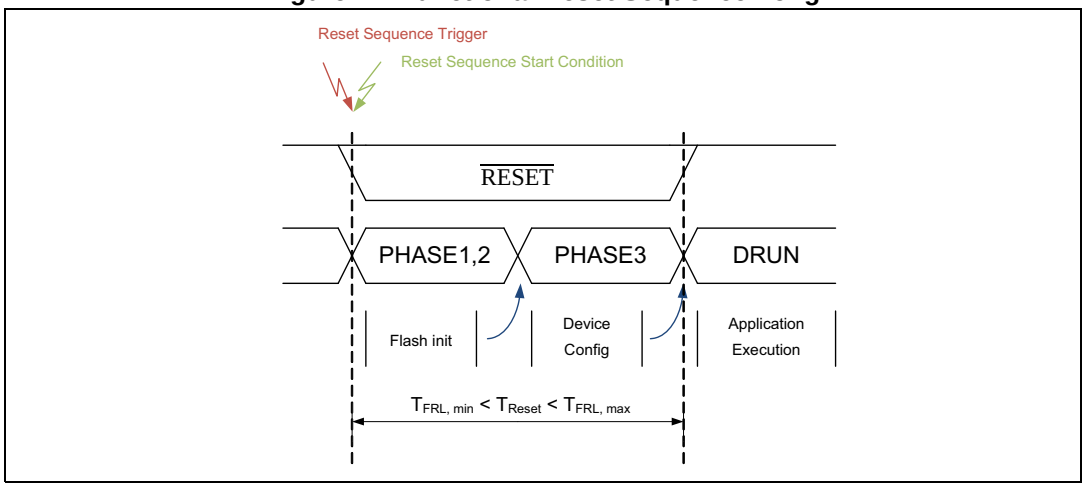
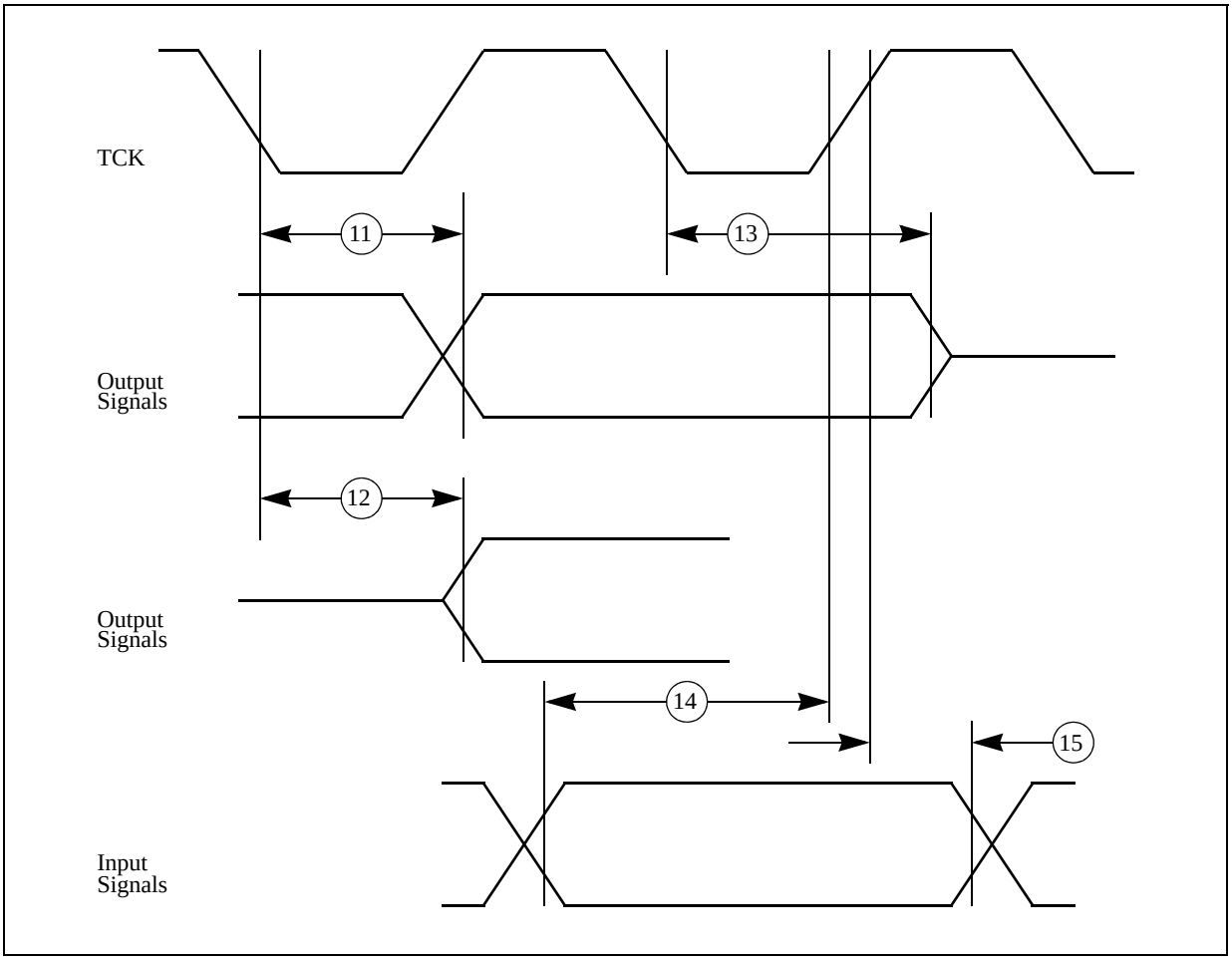


Figure 26. JTAG boundary scan timing



3.21.4 Nexus timing

Table 39. Nexus debug port timing(1)

No.	Symbol		Parameter	Conditions	Min	Max	Unit
1	t_{MCYC}	D	MCKO Cycle Time	—	15.6	—	ns
2	t_{MDC}	D	MCKO Duty Cycle	—	40	60	%
3	t_{MDOV}	D	MCKO Low to MDO, $\overline{MSEO}$, $\overline{EVTO}$ Data Valid(2)	—	–0.1	0.25	t_{MCYC}
4	t_{EVTIPW}	D	$\overline{EVTI}$ Pulse Width	—	4.0	—	t_{TCYC}
5	t_{EVTOPW}	D	$\overline{EVTO}$ Pulse Width	—	1		t_{MCYC}
6	t_{TCYC}	D	TCK Cycle Time(3)	—	62.5	—	ns
7	t_{TDC}	D	TCK Duty Cycle	—	40	60	%
8	t_{NTDIS}, t_{NTMSS}	D	TDI, TMS Data Setup Time	—	8	—	ns

Figure 29. Nexus Double Data Rate (DDR) Mode output timing

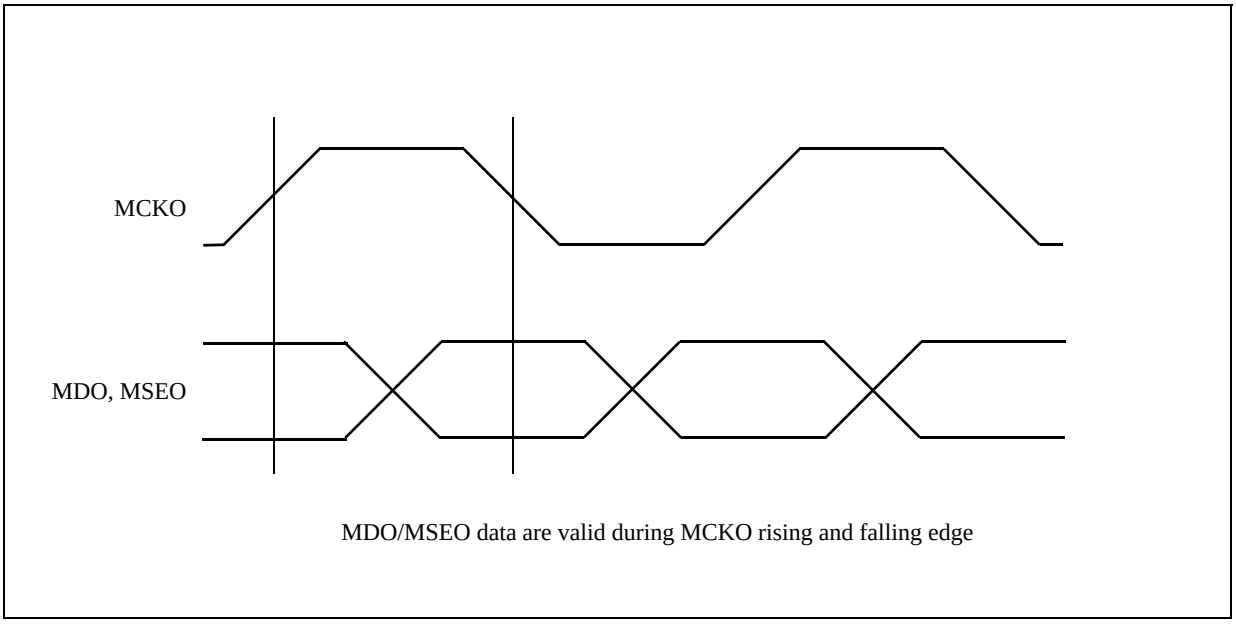
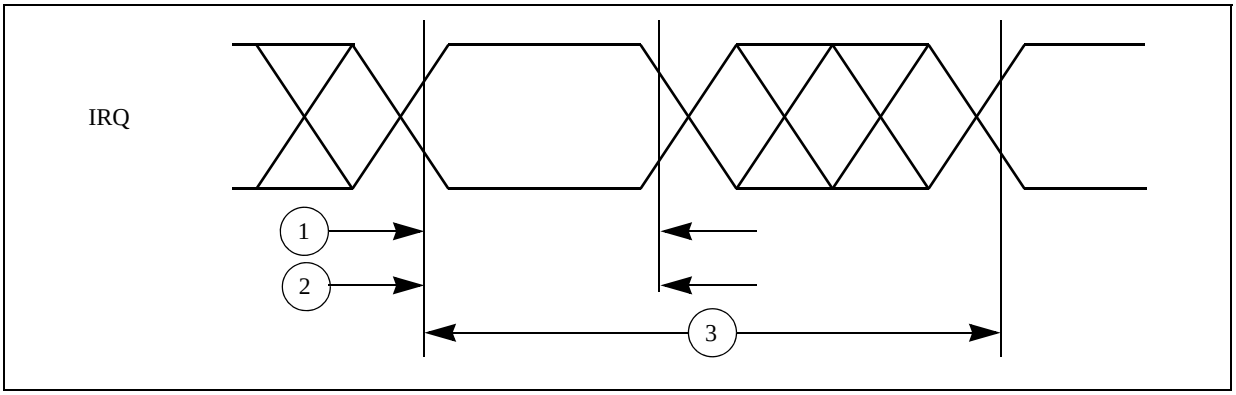


Figure 31. External interrupt timing

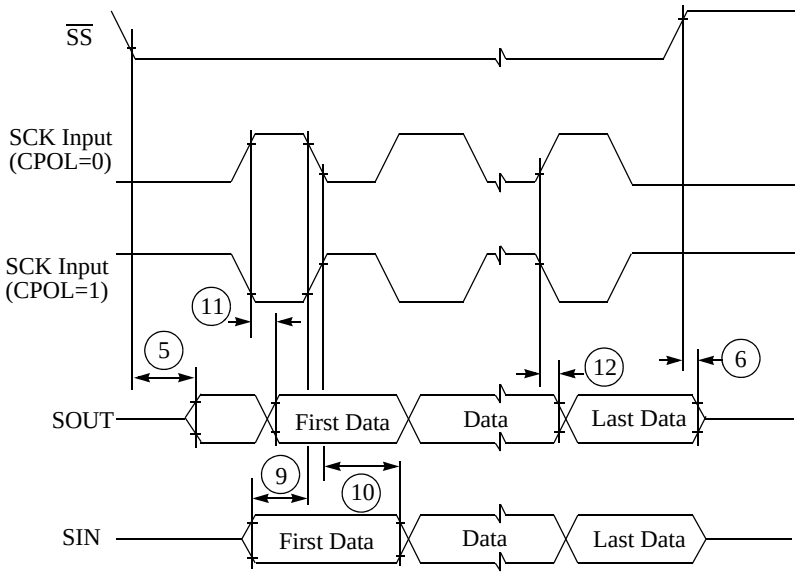


3.21.6 DSPI timing

Table 41. DSPI timing

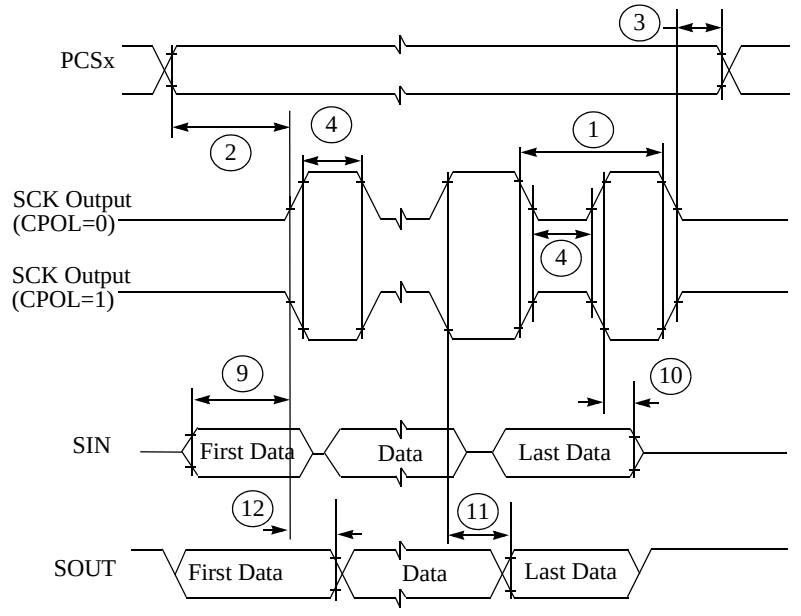
No.	Symbol		Parameter	Conditions	Min	Max	Unit
1	t_{SCK}	D	DSPI cycle time	Master (MTFE = 0)	62	—	ns
		D		Slave (MTFE = 0)	62	—	
		D		Slave Receive Only Mode(1)	16	—	
2	t_{CSC}	D	PCS to SCK delay	—	16	—	ns
3	t_{ASC}	D	After SCK delay	—	16	—	ns
4	t_{SDC}	D	SCK duty cycle	—	$t_{SCK}/2$ - 10	$t_{SCK}/2$ + 10	ns
5	t_A	D	Slave access time	$\overline{SS}$ active to SOUT valid	—	40	ns
6	t_{DIS}	D	Slave SOUT disable time	$\overline{SS}$ inactive to SOUT High-Z or invalid	—	10	ns
7	t_{PCSC}	D	PCSx to $\overline{PCSS}$ time	—	13	—	ns
8	t_{PASC}	D	$\overline{PCSS}$ to PCSx time	—	13	—	ns
9	t_{SUI}	D	Data setup time for inputs	Master (MTFE = 0)	20	—	ns
				Slave	2	—	
				Master (MTFE = 1, CPHA = 0)	5	—	
				Master (MTFE = 1, CPHA = 1)	20	—	
10	t_{HI}	D	Data hold time for inputs	Master (MTFE = 0)	–5	—	ns
				Slave	4	—	
				Master (MTFE = 1, CPHA = 0)	11	—	
				Master (MTFE = 1, CPHA = 1)	–5	—	
11	t_{SUO}	D	Data valid (after SCK edge)	Master (MTFE = 0)	—	4	ns
				Slave	—	23	
				Master (MTFE = 1, CPHA = 0)	—	12	
				Master (MTFE = 1, CPHA = 1)	—	4	

Figure 35. DSPI classic SPI timing — slave, CPHA = 1



Note: The numbers shown are referenced in *Table 41*.

Figure 36. DSPI modified transfer format timing — master, CPHA = 0



Note: The numbers shown are referenced in *Table 41*.

Table 43. LQFP144 mechanical data (continued)

Symbol	mm			inches[1]		
	Typ	Min	Max	Typ	Min	Max
E3	17.5			0.6890		
e	0.5			0.0197		
L	0.6	0.45	0.75	0.0236	0.0177	0.0295
L1	1			0.0394		
k	3.5°	0.0°	7.0°	3.5°	0.0°	7.0°
Tolerance	mm			inches		
ccc	0.08			0.0031		

1. Values in inches are converted from mm and rounded to four decimal digits.

Figure 43. LFBGA257 package mechanical drawing

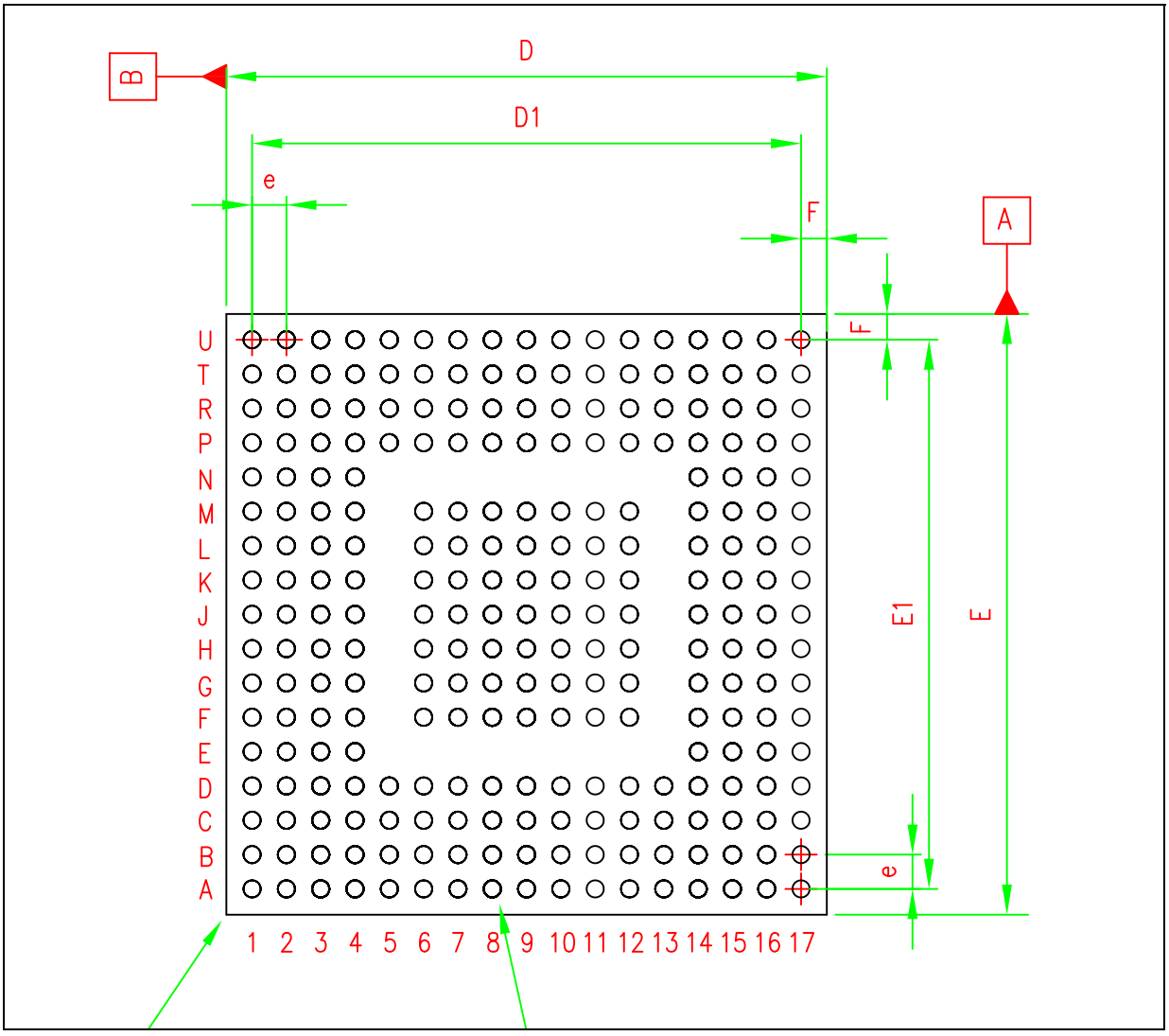


Table 45. Document revision history

Date	Revision	Changes
14-Jun-2010	4 (continued)	In the “Main oscillator electrical characteristics” table, changed the maximum specification for $g_{mXOSCHS}$ (was 11 mA/V, is 11.8 mA/V). Revised the “ADC electrical characteristics” section.In the “ADC conversion characteristics” table: – Changed the t_{ADC_S} specification (was TBD, is minimum of 383 ns). – Added the footnote “No missing codes” to the DNL specification. – Added specifications for SNR, THD, SINAD, and ENOB. Revised the “Ordering information” section.
23-Nov-2010	5	Editorial changes and improvements. Revised the Overview section. Replaced references to PowerPC with references to Power Architecture. In the feature summary, changed “As much as 128 KB on-chip SRAM” to “128 KB on-chip SRAM”. In the “Feature details” section: – In the “On-chip SRAM with ECC” section, added information about required RAM wait states. – In the PIT section, deleted “32-bit counter for real time interrupt, clocked from main external oscillator” (not supported on this device). – In the flash-memory section, changed “16 KB Test” to “16 KB test sector”, revised the wait state information, and deleted the associated Review_Q&A content. – In the SRAM section, revised the wait state information. In the 100-pin pinout diagram: – Renamed pin 41 (was VDD_HV_ADV0_ADV1, is VDD_HV_ADV). – Renamed pin 42 (was VSS_HV_ADV0_ADV1, is VSS_HV_ADV). In the 144-pin pinout diagram: – Renamed pin 58 (was VDD_HV_ADV0_ADV1, is VDD_HV_ADV). – Renamed pin 59 (was VSS_HV_ADV0_ADV1, is VSS_HV_ADV). Added the “LQFP100 pin function summary” table. In the “LQFP144 pin function summary” table, for pin 39, changed $V_{SS\_LV\_COR}$ to $V_{DD\_LV\_COR}$. In the “Supply pins” table: – Changed the description for $V_{DD\_LV\_COR}$ (was “Voltage regulator supply voltage”, is “Core logic supply”). – Changed the description for $V_{DD\_HV\_PMU}$ (was “Core regulator supply”, is “Voltage regulator supply”). In the “Pin muxing” table: – In the “Pad speed” column headings, changed “SRC = 0” to “SRC = 1” and “SRC = 1” to “SRC = 0” – For port B[6], changed the pad speed for SRC=0 (was M, is F). In the “Thermal characteristics” section, added meaningful values to the thermal-characteristics tables. Added the “SWG electrical specifications” section. In the “Voltage regulator electrical characteristics” section, changed the table title (was “HPREG1, HPREG2, Main LVDs, Digital HVD, and Digital LVD electrical specifications”, is “Voltage regulator electrical characteristics”) and revised the table.

Table 45. Document revision history

Date	Revision	Changes
18-Sep-2013	10	– Updated Disclaimer.
07-Feb-2014	11	– Removed “TBC” symbol in *Table 9* and *Table 22* – Resolved some cross references.
08-Jul-2015	12	Editorial and formatting changes throughout document. *Chapter 1: Introduction*: – In *Table 1: SPC56ELx/SPC564Lx device summary* added the column for SPC56EL54 device *Chapter 3: Electrical characteristics*: – In *Table 9: Absolute maximum ratings*, added condition “Valid only for ADC pins” for V_{IN} Symbol. – Added *Section 3.4: Decoupling capacitors*. – *Figure 10: Input Equivalent Circuit*: changed “V_{DD}” to “V_{REF}” in Internal circuit scheme – In *Table 32: Pad AC specifications (3.3 V, IPP_HVE = 0)* updated footnote 1 and footnote 2. – Updated *Figure 13: Pad output delay* Updated Disclaimer.